Introduction à l'apprentissage automatique - Polytech Empirical risk minimization

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Theory

Problem

Train/test objective mismatch

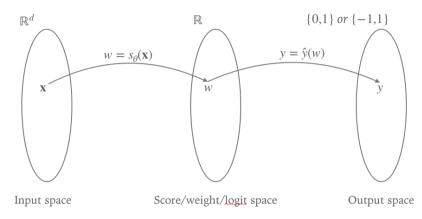
- ▶ At training time we minimize a loss function, *e.g.* the hinge loss
- At test time we evaluate the model using a different function, e.g. classification error / classification accuracy

There is a mismatch between the two objective!

Goal

Can we prove that minimizing a given loss function also minimizes the test time objective?

Assumptions



- We assume the class of scoring functions S is "rich enough" (*i.e.* set of all measurable mappings)
- We assume we have access to an infinite number of training datapoints

0-1 loss function

Definition of the 0-1 loss function

Count the number of classification errors

 \Rightarrow exactly what we aim to minimize at test time

Binary classification

If Y = {0,1}:
$$\ell_{0-1}(y,w) = 1[(2y-1)w < 0] = [sign(w) ≠ 2y - 1]$$
If Y = {-1,1}: $\ell_{0-1}(y,w) = 1[y × w < 0] = [sign(w) ≠ y]$

Multiclass classification

► If
$$Y = E(k)$$
:
 $\ell_{0-1}(\boldsymbol{y}, \boldsymbol{w}) = \begin{cases} 0 & \text{if } \boldsymbol{y} = \arg \max_{\boldsymbol{y}' \in E(k)} \langle \boldsymbol{w}, \boldsymbol{y}' \rangle, \\ 1 & \text{otherwise.} \end{cases}$

▶ If
$$Y = \{1, ..., k\}$$
:
 $\ell_{0-1}(y, w) = \mathbb{1}[y \neq \underset{y' \in \{1, ..., k\}}{\operatorname{arg\,max}} w_{y'}]$

Bayes risk

Notations

- ▶ **x**: random variable representing inputs in \mathbb{R}^d
- ▶ y: random variable representing outputs, problem dependent
- > $p(\mathbf{x}, \mathbf{y})$: data distribution, unknown in practice but we can still use it for theory
- ► S: set of scoring functions

WARNING

The input/output mapping in the data distribution is not necessarily deterministic, an input $\mathbf{x} \in \mathbb{R}^d$ may be associated with several outputs with a non null probability.

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Risk of a scoring function

The risk of a given scoring function $s \in S$ is denoted:

$$r(s) = \mathbb{E}_{\mathbf{x},\mathbf{y}}[\ \ell_{0-1}(\mathbf{y}, s(\mathbf{x}))\]$$

or, in other words, it is the classification error probability for classifier based on s.

Minimum Bayes risk

Risk of a scoring function

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Minimum Bayes risk

It seems that it is a good idea to aim for a model of minimum Bayes risk:

$$r^* = \inf_{s \in S} r(s) = \inf_{s \in S} \mathbb{E}_{\mathbf{x}, \mathbf{y}} [\ell_{0-1}(\mathbf{y}, s(\mathbf{x}))]$$
$$= \inf_{s \in S} \mathbb{E}_{\mathbf{x}} [\mathbb{E}_{\mathbf{y}|\mathbf{x}} [\ell_{0-1}(\mathbf{y}, s(\mathbf{x}))]]$$
$$= \mathbb{E}_{\mathbf{x}} [1 - \max_{\mathbf{y} \in Y} p(\mathbf{y} = \mathbf{y}|\mathbf{x})]$$

Surrogate losses

Recall

In practice we cannot use the 0-1 loss:

- non-convex
- partial derivatives are null almost everywhere

It is known that minimizing the 0-1 loss is a NP-hard problem (Ben-David et al., 2003; Feldman et al., 2009)

Main idea

- Replace the 0-1 loss with a surrogate loss
- hope (prove?) that minimizing the surrogate loss leads to a classifier of minimum Bayes risk

Classification calibration

Surrogate risk Let $\tilde{\ell}$ be a surrogate loss. The surrogate risk $\tilde{r}(s)$ of scoring function $s \in S$ is defined as:

$$\widetilde{r}(s) = \mathbb{E}_{\mathbf{x},\mathbf{y}}[\ \widetilde{\ell}(\mathbf{y},s(\mathbf{x}))\],$$

and the optimal surrogate risk \tilde{r}^* is defined as:

$$\widetilde{r}^* = \inf_{s \in S} \widetilde{r}(s) = \inf_{s \in S} \mathbb{E}_{\mathbf{x},\mathbf{y}} [\ \widetilde{\ell}(\mathbf{y}, s(\mathbf{x}))]$$

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$$\widetilde{r}^* = \inf_{s \in S} \widetilde{r}(s) = \inf_{s \in S} \mathbb{E}_{\mathbf{x},\mathbf{y}} [\ \widetilde{\ell}(\mathbf{y}, s(\mathbf{x})) \]$$

Definition

A surrogate loss $\tilde{\ell}$ is said to be **classification calibrated** if and only if:

$$s^* \in \operatorname*{arg\,min}_{s \in S} \widetilde{r}(s) \implies r(s^*) = r^*,$$

i.e. minimizing the surrogate risk leads to a prediction model of optimal Bayes risk. This property is also called Bayes consistency and Fisher consistency.

Pointwise analysis 1/2

Assumption

We assume the class of scoring function S is "rich enough" (*i.e.* set of all measurable mappings)

$$r^{*} = \inf_{s \in S} r(s) = \inf_{s \in S} \mathbb{E}_{\mathbf{x}, \mathbf{y}} \left[\ell_{0-1}(s(\mathbf{x}), \mathbf{y}) \right]$$
$$= \inf_{\forall \mathbf{x} \in X: \ \mathbf{w}^{(\mathbf{x})} \in \mathbb{R}^{k}} \mathbb{E}_{\mathbf{x}} \left[\mathbb{E}_{\mathbf{y}|\mathbf{x}} \left[\ell_{0-1}(\mathbf{y}, \mathbf{w}^{(\mathbf{x})}) \right] \right]$$
$$= \mathbb{E}_{\mathbf{x}} \left[\inf_{\mathbf{w}^{(\mathbf{x})} \in \mathbb{R}^{k}} \mathbb{E}_{\mathbf{y}|\mathbf{x}} \left[\ell_{0-1}(\mathbf{y}, \mathbf{w}^{(\mathbf{x})}) \right] \right]$$
We can focus on this part only

Pointwise analysis 1/2

Assumption

We assume the class of scoring function S is "rich enough" (*i.e.* set of all measurable mappings)

Pointwise risk

Let $x \in X$ such that p(x = x) > 0. We redefine the concept of (optimal) surrogate/Bayes risk as follows:

$$r(\boldsymbol{w}) = \mathbb{E}_{\mathbf{y}|\mathbf{x}=\mathbf{x}} [\ell_{0-1}(\mathbf{y}, \boldsymbol{w})] \qquad \qquad \widetilde{r}(\boldsymbol{w}) = \mathbb{E}_{\mathbf{y}|\mathbf{x}=\mathbf{x}} [\widetilde{\ell}(\mathbf{y}, \boldsymbol{w})]$$
$$r^* = \inf_{\boldsymbol{w} \in \mathbb{R}^k} r(\boldsymbol{w}) \qquad \qquad \widetilde{r}^* = \inf_{\boldsymbol{w} \in \mathbb{R}^k} \widetilde{r}(\boldsymbol{w})$$

where $\boldsymbol{w} \in \mathbb{R}^k$ should be interpreted as the output of the scoring function, *i.e.* $\boldsymbol{w} = \boldsymbol{s}(\boldsymbol{x})$.

Classification calibration for binary classification

Surrogate losses

Let $Y = \{-1, 1\}.$

- ▶ Perceptron loss: $\tilde{\ell}_{perceptron}(y, w) = \max(0, -y \times w)$
- ► Hinge loss: $\tilde{\ell}_{hinge}(y, w) = max(0, 1 y \times w)$
- ▶ Squared hinge loss: $\tilde{\ell}_{s. hinge}(y, w) = \max(0, 1 y \times w)^2$
- Exponential loss: $\tilde{\ell}_{exp}(y, w) = exp(-y \times w)$
- ▶ Negative log-likelihood (NLL): $\tilde{\ell}_{nll}(y, w) = \log(1 + \exp(-y \times w))$
- Quadratic error (or squared error): $\tilde{\ell}_{quad.}(y, w) = (y \times w 1)^2$

Classification calibration

All these surrogate losses are classification calibrated except the perceptron loss.

Classification calibration for binary classification

Surrogate risk $$\begin{split} \widetilde{r}(w) &= \mathbb{E}_{\mathbf{y}|\mathbf{x}=\mathbf{x}} \left[\ \widetilde{\ell}(\mathbf{y}, w) \ \right] \\ &= p(\mathbf{y} = 1 | \mathbf{x} = \mathbf{x}) \times \widetilde{\ell}(1, w) + p(\mathbf{y} = -1 | \mathbf{x} = \mathbf{x}) \times \widetilde{\ell}(-1, w) \\ &= \mu \times \widetilde{\ell}(1, w) + (1 - \mu) \times \widetilde{\ell}(-1, w) \end{split}$$

where $\mu = p(\mathbf{y} = 1 | \mathbf{x} = \mathbf{x})$. The optimal surrogate risk is:

$$\widetilde{r}^* = \inf_{w \in \mathbb{R}} \widetilde{r}(w) = \inf_{w \in \mathbb{R}} \ \mu imes \widetilde{\ell}(1,w) + (1-\mu) imes \widetilde{\ell}(-1,w)$$

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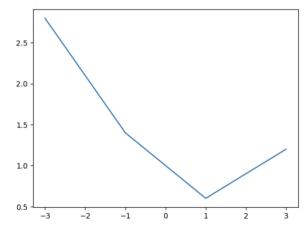
Intuition

The surrogate loss $\tilde{\ell}$ is classification calibrated if the minimzer w^* satisfies:

µ > 0.5 ⇒ w* ≥ 0 (the class 1 is the most probable class for input x)
 µ < 0.5 ⇒ w* < 0 (the class 1 is the most probable class for input x)
 µ = 0.5: this case is not important.

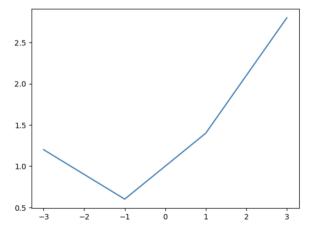
```
[4]: def hinge(y, w):
    return max(0, 1 - y * w)
mu = 0.7
ws = np.linspace(-3, 3, 100)
ls = [mu * hinge(1, w) + (1 - mu) * hinge(-1, w) for w in ws]
plt.plot(ws, ls)
```

[4]: [<matplotlib.lines.Line2D at 0x10f41f0a0>]



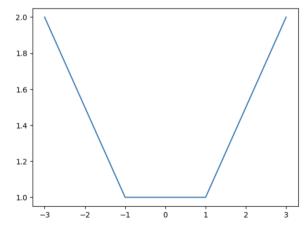
```
[5]: def hinge(y, w):
    return max(0, 1 - y * w)
mu = 0.3
ws = np.linspace(-3, 3, 100)
ls = [mu * hinge(1, w) + (1 - mu) * hinge(-1, w) for w in ws]
plt.plot(ws, ls)
```

[5]: [<matplotlib.lines.Line2D at 0x10f2313c0>]



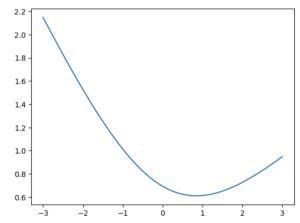
```
[6]: def hinge(y, w):
    return max(0, 1 - y * w)
mu = 0.5
ws = np.linspace(-3, 3, 100)
ls = [mu * hinge(1, w) + (1 - mu) * hinge(-1, w) for w in ws]
plt.plot(ws, ls)
```

[6]: [<matplotlib.lines.Line2D at 0x10ff3c820>]



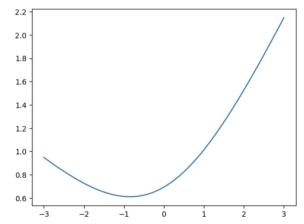
```
[7]: def nll(y, w):
    return np.log(1 + np.exp(- y * w))
mu = 0.7
ws = np.linspace(-3, 3, 100)
ls = [mu * nll(1, w) + (1 - mu) * nll(-1, w) for w in ws]
plt.plot(ws, ls)
```

[7]: [<matplotlib.lines.Line2D at 0x10ff9e290>]



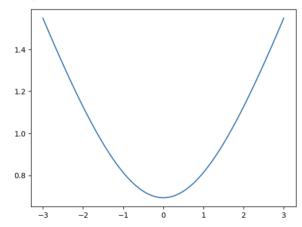
```
[8]: def nll(y, w):
    return np.log(1 + np.exp(- y * w))
mu = 0.3
ws = np.linspace(-3, 3, 100)
ls = [mu * nll(1, w) + (1 - mu) * nll(-1, w) for w in ws]
plt.plot(ws, ls)
```

[8]: [<matplotlib.lines.Line2D at 0x11002ded0>]



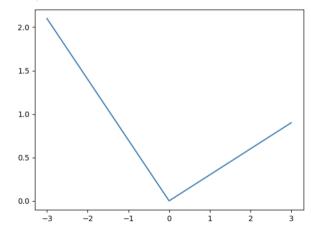
```
[9]: def nll(y, w):
    return np.log(1 + np.exp(- y * w))
mu = 0.5
ws = np.linspace(-3, 3, 100)
ls = [mu * nll(1, w) + (1 - mu) * nll(-1, w) for w in ws]
plt.plot(ws, ls)
```

[9]: [<matplotlib.lines.Line2D at 0x1100b94b0>]



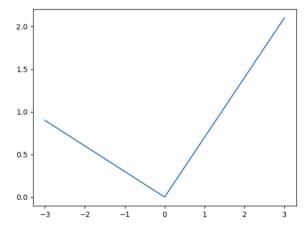
```
[14]: def perceptron(y, w):
    return max(0, - y * w)
mu = 0.7
ws = np.linspace(-3, 3, 1000)
ls = [mu * perceptron(1, w) + (1 - mu) * perceptron(-1, w) for w in w
plt.plot(ws, ls)
```

[14]: [<matplotlib.lines.Line2D at 0x110325a80>]



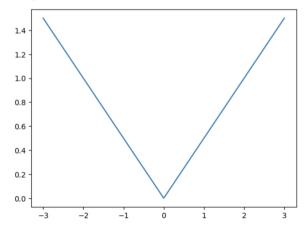
```
[15]: def perceptron(y, w):
    return max(0, - y * w)
mu = 0.3
ws = np.linspace(-3, 3, 1000)
ls = [mu * perceptron(1, w) + (1 - mu) * perceptron(-1, w) for w in ws]
plt.plot(ws, ls)
```

[15]: [<matplotlib.lines.Line2D at 0x11039ad70>]





[16]: [<matplotlib.lines.Line2D at 0x1104156f0>]



Sufficient conditions in the binary case

Let $\widetilde{\ell}: \{-1,1\} \times \mathbb{R} \to \mathbb{R}_+$ be a surrogate loss function that can be rewrittent as:

$$\widetilde{\ell}(\mathsf{y},\mathsf{w}) = \phi(\mathsf{y}\mathsf{w})$$

where $\phi : \mathbb{R} \to \mathbb{R}_+$ is function.

 \Rightarrow all previously presented binary loss function can be rewritten under this form.

Theorem

If ϕ is convex and differentiable at 0 with $\phi'(0) <$ 0, then $\widetilde{\ell}$ is classification calibrated

Proof

See (Lin, 2004).

Classification calibration for multiclass classification

Surrogate losses

Let Y = E(k).

$$\blacktriangleright \text{ Hinge loss: } \widetilde{\ell}_{\mathsf{hinge}}(\boldsymbol{y}, \boldsymbol{w}) = \max\left(0, 1 - \langle \boldsymbol{y}, \boldsymbol{w} \rangle + \max_{\boldsymbol{y}' \in \boldsymbol{E}(k) \setminus \{\boldsymbol{y}\}} \langle \boldsymbol{y}', \boldsymbol{w} \rangle\right)$$

► NLL:
$$\tilde{\ell}_{nll}(\boldsymbol{y}, \boldsymbol{w}) = -\langle \boldsymbol{y}, \boldsymbol{w} \rangle + \log \sum_{i} \exp(w_i)$$

Properties without proof

In the multiclass classification case:

- ▶ The hinge loss is not classification calibrated, see (Liu, 2007)
- The NLL loss is classification calibrated, see exercises

Strictly proper losses 1/2

Probabilistic prediction model

- ► We saw that we can learn models that predict a probability distribution over outputs, *e.g.* p_s(y|x), where the s emphasize that this is the learned model distribution, parameterized by the scoring function s.
- Classification calibration means the the most probable output in the data distribution will also be the most probable output in the model distribution
- ▶ We may want a stronger property: that the two distributions are equal

Strictly proper losses 1/2

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- ▶ We may want a stronger property: that the two distributions are equal

Definition

Let $p(\mathbf{y}, \mathbf{x})$ be the data distribution and $p_s(\mathbf{y}|\mathbf{x})$ the model distribution. In the pointwise setting, a surrogate loss $\tilde{\ell}$ is **classification calibrated** if and only if the scoring function s^* that minimizes the surrogate risk leads to a model distribution equal to the data distribution:

$$\forall \mathbf{y} \in Y: \quad p_{s^*}(\mathbf{y} = \mathbf{y} | \mathbf{x} = \mathbf{x}) = p(\mathbf{y} = \mathbf{y} | \mathbf{x} = \mathbf{x}).$$

Strictly proper losses 1/2

Remarks

- Strict properness implies classification calibration
- The support of the data distribution must be "representable" by the model distribution
- The NLL loss is strictly proper for models whose probability parameters are computed using the sigmoid/softmax function if the conditional data distribution has full support.

Risk minimization decomposition

Practical issues

- We only have access to a finite training dataset
- \blacktriangleright The set of function S is not the set of all measurable mapping
- The learning algorithm may not find the optimal classifier $s \in S$, *i.e.* the following problem may be solved approximately

$$s^* \in \operatorname*{arg\,min}_{s \in S} rac{1}{|D|} \sum_{(m{x},m{y}) \in D} \ell(m{y}, s(m{x})),$$

or in other words, in practice the computed s^* is not a minimizer.

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0

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Risk decomposition

Excess risk:
$$r(s^*) - r^* \ge$$

Excess risk decomposition:

$$r(s^*) - r^* = \underbrace{r(s^*) - \inf_{s \in S} r(s)}_{\text{Estimation error}} + \underbrace{\inf_{s \in S} r(s) - r^*}_{\text{Approximation error}}$$